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| Notice of References Cited | Application/Control No. 10/076,178 | Applicant(s)/Patent Under Reexamination JOHNSON, MORGAN T. | |
| | Examiner DuyVu n Deo | Art Unit 1765 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-6,048,755 | 04-2000 | Jiang et al. | 438/118 |
| | B | US-6,376,769 | 04-2002 | Chung, Kevin Kwong-Tai | 174/52.2 |
| | C | US-5,593,606 | 01-1997 | Owen et al. | 219/121.71 |
| | D | US-5,841,099 | 11-1998 | Owen et al. | 219/121.69 |
| | E | US-5,614,114 | 03-1997 | Owen, Mark D. | 219/121.66 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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